

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination KREMER ET AL.	
		Examiner Allen H. Nguyen	Art Unit 2625	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0222916	12-2003	Kuwata et al.	345/777
*	B	US-2005/0206954	09-2005	Schwier et al.	358/001.16
*	C	US-2004/0085583	05-2004	Yamamura, Shinichi	358/001.18
*	D	US-2003/0197882	10-2003	Tsukuba et al.	358/1.12
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

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